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FDD6672A

April 2001

FAIRCHILD

SEMICONDUCTOR TM

FDD6672A

30V N-Channel PowerTrench[®] MOSFET

General Description

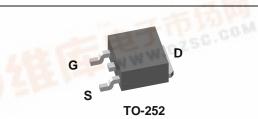
This N-Channel MOSFET has been designed specifically to improve the overall efficiency of DC/DC converters using either synchronous or conventional switching PWM controllers. It has been optimized for low gate charge, low $R_{DS(ON)}$ and fast switching speed.

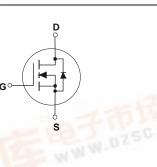
Applications

DC/DC converter

Features

- 65 A, 30 V. $R_{DS(ON)} = 9.5 \text{ m}\Omega @ V_{GS} = 4.5 \text{ V}$ $R_{DS(ON)} = 8 \text{ m}\Omega @ V_{GS} = 10 \text{ V}$
- High performance trench technology for extremely low R_{DS(ON)}
- Low gate charge (33 nC typical)
- High power and current handling capability





Absolute Maximum Ratings T_A=25°C unless otherwise noted

| Symbol | Parameter | N8 - | Ratings | Units |
|-----------------------------------|--|--------|-------------|-------|
| V _{DSS} | Drain-Source Voltage | | 30 | V |
| V _{GSS} | Gate-Source Voltage | | ±12 | V |
| I _D | Drain Current – Continuous (Not | te 1a) | 65 | A |
| | – Pulsed | | 100 | |
| PD | Maximum Power Dissipation @ $T_c = 25^{\circ}C$ (No. | ote 1) | 70 | W |
| | @ $T_A = 25^{\circ}C$ (Not | te 1a) | 3.2 | 121 |
| | @ $T_A = 25^{\circ}C$ (Not | te 1b) | 1.3 | 10 10 |
| T _J , T _{STG} | Operating and Storage Junction Temperature Range | | -55 to +150 | °C |
| Therma | I Characteristics | 54 | WWW S | - |
| Raic | Thermal Resistance, Junction-to-Case | ote 1) | 1.8 | °C/W |

| | L TU 2 - all | | | |
|-----------------|---|-----------|-----|------|
| $R_{\theta JA}$ | Thermal Resistance, Junction-to-Ambient | (Note 1b) | 96 | °C/W |
| $R_{\theta JC}$ | Thermal Resistance, Junction-to-Case | (Note 1) | 1.8 | °C/W |

Package Marking and Ordering Information

| Device Marking | Device | Reel Size | Tape width | Quantity |
|----------------|----------|-----------|------------|------------|
| FDD6672A | FDD6672A | 13" | 16mm | 2500 units |



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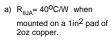
FDD6672A Rev C (W)

| Symbol | Parameter | Test Conditions | Min | Тур | Max | Units |
|--|---|--|-----|--------------------|----------------|-------|
| Off Char | acteristics | | | | | |
| BV _{DSS} | Drain-Source Breakdown Voltage | $V_{GS} = 0 V, I_D = 250 \mu A$ | 30 | | | V |
| $\frac{\Delta BV_{DSS}}{\Delta T_J}$ | Breakdown Voltage Temperature Coefficient | $I_D = 250 \ \mu\text{A}$, Referenced to 25°C | | 20 | | mV/°C |
| IDSS | Zero Gate Voltage Drain Current | $V_{DS} = 24 \text{ V}, V_{GS} = 0 \text{ V}$ | | | 1 | μA |
| I _{GSSF} | Gate–Body Leakage, Forward | $V_{GS} = 12 \text{ V}, V_{DS} = 0 \text{ V}$ | | | 100 | nA |
| I _{GSSR} | Gate-Body Leakage, Reverse | $V_{GS} = -12 \ V \ V_{DS} = 0 \ V$ | | | -100 | nA |
| On Char | acteristics (Note 2) | | | | | |
| V _{GS(th)} | Gate Threshold Voltage | $V_{DS} = V_{GS}, I_D = 250 \ \mu A$ | 0.8 | 1.2 | 2.0 | V |
| $\frac{\Delta V_{GS(th)}}{\Delta T_J}$ | Gate Threshold Voltage Temperature Coefficient | $I_D = 250 \ \mu$ A, Referenced to 25° C | | -4 | | mV/°C |
| R _{DS(on)} | Static Drain–Source On–Resistance | | | 8.2 11.5 6.8 | 9.5 16 8 | mΩ |
| I _{D(on)} | On–State Drain Current | $V_{GS} = 10 \text{ V}, V_{DS} = 5 \text{ V}$ | 50 | | | Α |
| g _{FS} | Forward Transconductance | $V_{DS} = 10 \text{ V}, \qquad I_D = 15 \text{ A}$ | | 75 | | S |
| Dynamic | Characteristics | | | | | |
| Ciss | Input Capacitance | $V_{DS} = 15 V, V_{GS} = 0 V,$ | | 5070 | | pF |
| Coss | Output Capacitance | f = 1.0 MHz | | 550 | | pF |
| Crss | Reverse Transfer Capacitance | | | 230 | | pF |
| Switchin | g Characteristics (Note 2) | | | | | |
| t _{d(on)} | Turn–On Delay Time | $V_{DD} = 10 V, I_D = 1 A,$ | | 17 | 25 | ns |
| t _r | Turn–On Rise Time | $V_{GS} = 4.5 V, R_{GEN} = 6 \Omega$ | | 18 | 25 | ns |
| t _{d(off)} | Turn–Off Delay Time |] | | 69 | 100 | ns |
| t _f | Turn–Off Fall Time |] | | 29 | 42 | ns |
| Qg | Total Gate Charge | $V_{DS} = 15 V, I_D = 15 A,$ | | 33 | 46 | nC |
| Q _{gs} | Gate–Source Charge | V _{GS} = 4.5 V | | 7.5 | | nC |
| Q _{gd} | Gate–Drain Charge |] | | 6.8 | | nC |
| Drain-Se | ource Diode Characteristics | and Maximum Ratings | | | | |
| ls | Maximum Continuous Drain-Source | Diode Forward Current | | | 2.7 | А |
| V _{SD} | Drain–Source Diode Forward Voltage | $V_{GS} = 0 V$, $I_S = 2.7 A$ (Note 2) | | 0.7 | 1.2 | V |

Notes:

1. R_{0JA} is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the drain tab. R_{0JC} is guaranteed by design while R_{0CA} is determined by the user's board design.



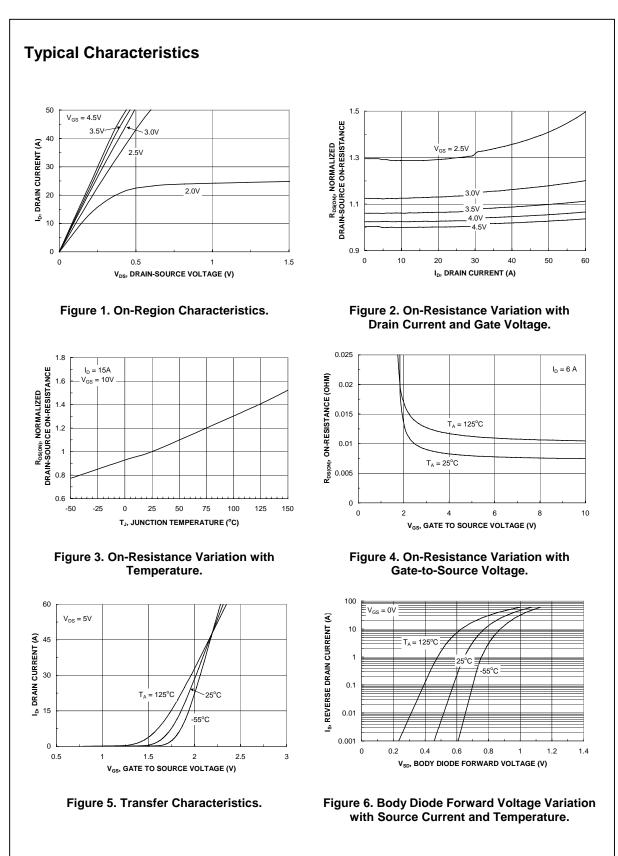




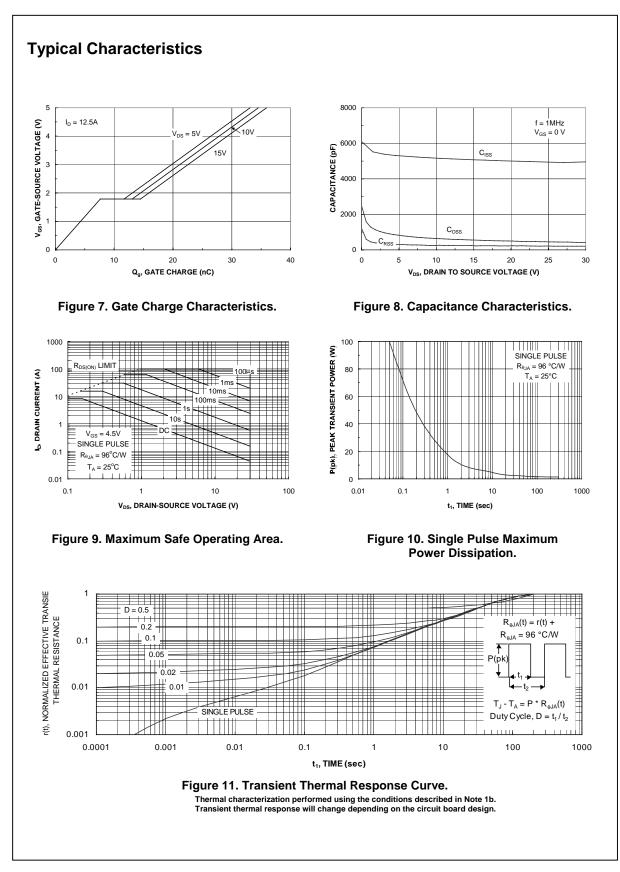
b) $R_{\theta JA}$ = 96^oC/W on a minimum mounting pad.

Scale 1 : 1 on letter size paper

2. Pulse Test: Pulse Width < 300 μ s, Duty Cycle < 2.0%



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| Datasheet Identification | Product Status | Definition | | |
|--------------------------|---------------------------|---|--|--|
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